

## N-channel 600 V, 0.550 $\Omega$ typ., 7.5 A MDmesh™ M2 EP Power MOSFET in an I<sup>2</sup>PAKFP package

Datasheet - production data

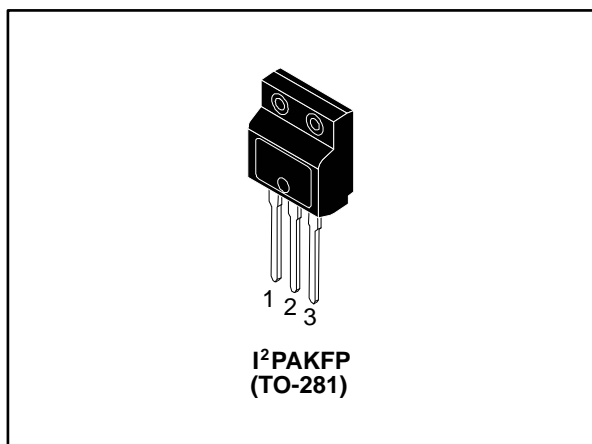


Figure 1: Internal schematic diagram

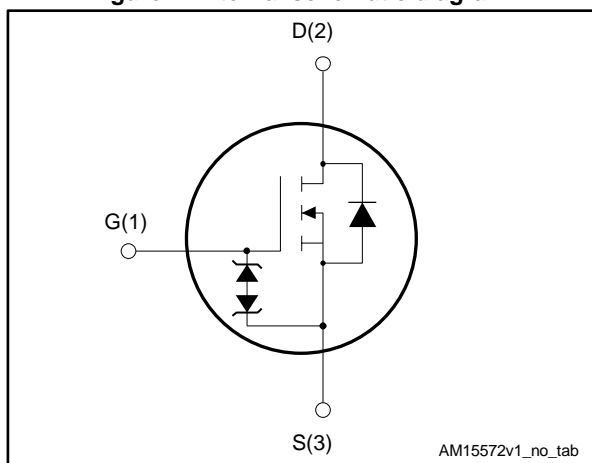


Table 1: Device summary

Order code	Marking	Package	Packaging
STFI11N60M2-EP	11N60M2EP	I <sup>2</sup> PAKFP (TO-281)	Tube

### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STFI11N60M2-EP	600 V	0.595 $\Omega$	7.5 A

- Extremely low gate charge
- Excellent output capacitance (C<sub>oss</sub>) profile
- Very low turn-off switching losses
- 100% avalanche tested
- Zener-protected
- Fully insulated and low profile package with increased creepage path from pin to heatsink plate

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 EP enhanced performance technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance, optimized switching characteristics with very low turn-off switching losses, rendering it suitable for the most demanding very high frequency converters.

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D$	Drain current (continuous) at $T_C = 25\text{ °C}$	7.5	A
$I_D$	Drain current (continuous) at $T_C = 100\text{ °C}$	4.7	A
$I_{DM}^{(1)}$	Drain current (pulsed)	30	A
$P_{TOT}$	Total dissipation at $T_C = 25\text{ °C}$	25	W
$dv/dt^{(2)}$	Peak diode recovery voltage slope	15	V/ns
$dv/dt^{(3)}$	MOSFET $dv/dt$ ruggedness	50	V/ns
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1\text{ s}$ , $T_C = 25\text{ °C}$ )	2.5	kV
$T_{stg}$	Storage temperature range	- 55 to 150	°C
$T_j$	Operating junction temperature range		

**Notes:**

(1)Pulse width limited by safe operating area.

(2) $I_{SD} \leq 7.5\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ;  $V_{DS\text{ peak}} < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$ .

(3) $V_{DS} \leq 480\text{ V}$

**Table 3: Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	5	°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient max	62.5	°C/W

**Table 4: Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )	2.4	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25\text{ °C}$ , $I_D = I_{AR}$ ; $V_{DD} = 50\text{ V}$ )	115	mJ

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified

**Table 5: On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$	600			V
$I_{DSS}$	Zero gate voltage Drain current	$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$ , $T_C = 125\text{ °C}$ <sup>(1)</sup>			100	$\mu\text{A}$
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 25\text{ V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	2	3	4	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 3.75\text{ A}$		0.550	0.595	$\Omega$

**Notes:**

<sup>(1)</sup>Defined by design, not subject to production test.

**Table 6: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0\text{ V}$	-	390	-	pF
$C_{oss}$	Output capacitance		-	22	-	pF
$C_{rss}$	Reverse transfer capacitance		-	0.7	-	pF
$C_{oss\text{ eq.}}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0\text{ to }480\text{ V}$ , $V_{GS} = 0\text{ V}$	-	49	-	pF
$R_G$	Intrinsic gate resistance	$f = 1\text{ MHz}$ , $I_D = 0\text{ A}$	-	6.5	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 480\text{ V}$ , $I_D = 7.5\text{ A}$ , $V_{GS} = 10\text{ V}$ (see <a href="#">Figure 16: "Test circuit for gate charge behavior"</a> )	-	12.4	-	nC
$Q_{gs}$	Gate-source charge		-	2.1	-	nC
$Q_{gd}$	Gate-drain charge		-	7	-	nC

**Notes:**

<sup>(1)</sup> $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

Table 7: Switching energy

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{\text{off}}$	Turn-off energy (from 90% $V_{\text{GS}}$ to 0% $I_{\text{D}}$ )	$V_{\text{DD}} = 400 \text{ V}$ , $I_{\text{D}} = 1 \text{ A}$ , $R_{\text{G}} = 4.7 \text{ } \Omega$ , $V_{\text{GS}} = 10 \text{ V}$	-	2.5	-	$\mu\text{J}$
		$V_{\text{DD}} = 400 \text{ V}$ , $I_{\text{D}} = 3 \text{ A}$ , $R_{\text{G}} = 4.7 \text{ } \Omega$ , $V_{\text{GS}} = 10 \text{ V}$	-	9	-	$\mu\text{J}$

Table 8: Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{\text{d(on)}}$	Turn-on delay time	$V_{\text{DD}} = 300 \text{ V}$ , $I_{\text{D}} = 3.75 \text{ A}$ , $R_{\text{G}} = 4.7 \text{ } \Omega$ , $V_{\text{GS}} = 10 \text{ V}$ (see <a href="#">Figure 15: "Test circuit for resistive load switching times"</a> and <a href="#">Figure 20: "Switching time waveform"</a> )	-	9	-	ns
$t_{\text{r}}$	Rise time		-	5.5	-	ns
$t_{\text{d(off)}}$	Turn-off-delay time		-	26	-	ns
$t_{\text{f}}$	Fall time		-	8	-	ns

Table 9: Source drain diode

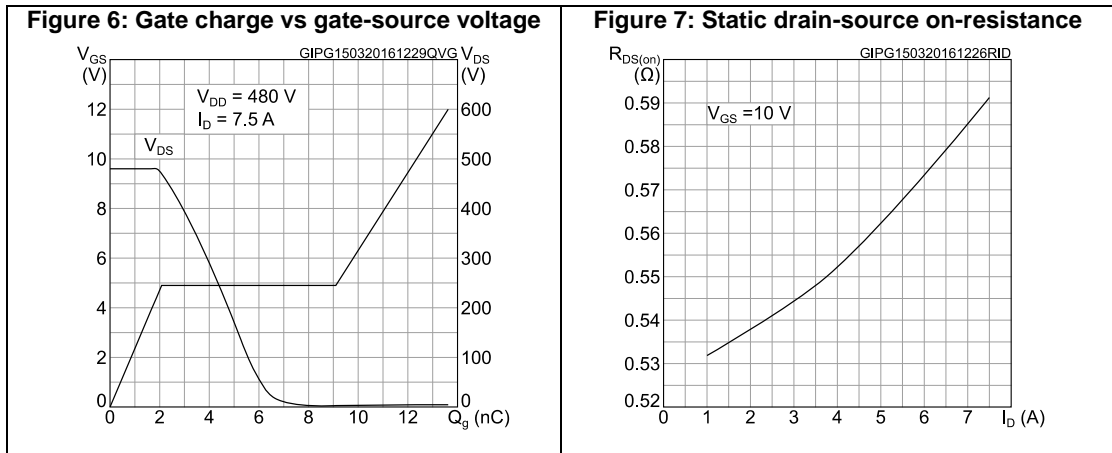
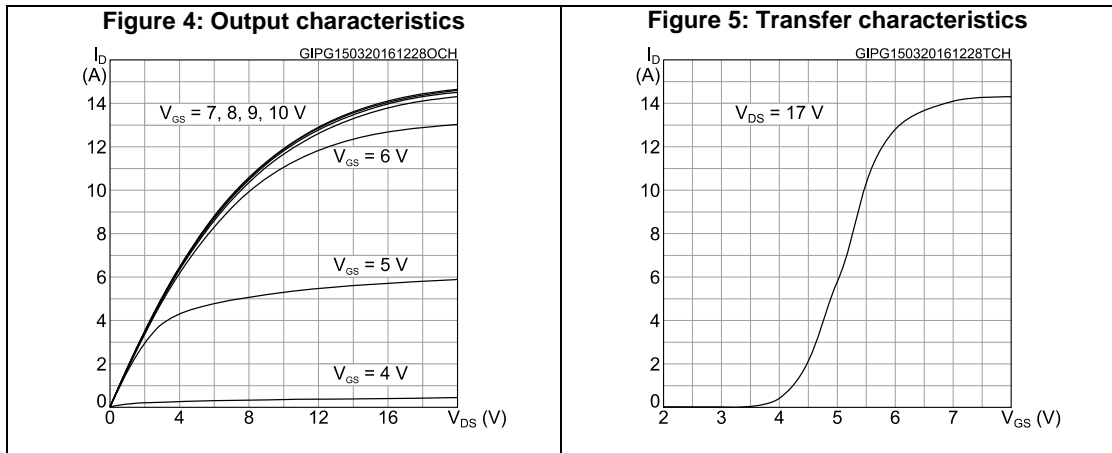
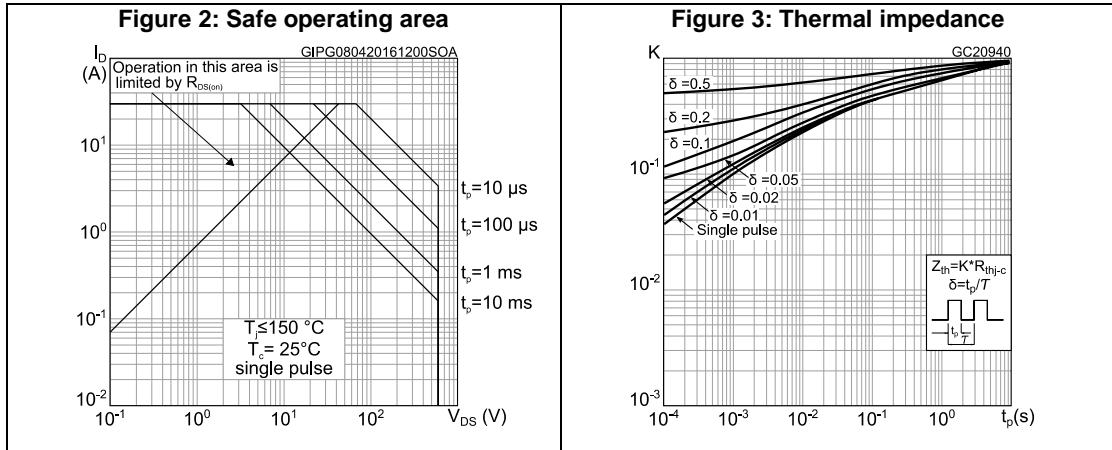
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{\text{SD}}$	Source-drain current		-		7.5	A
$I_{\text{SDM}}^{(1)}$	Source-drain current (pulsed)		-		30	A
$V_{\text{SD}}^{(2)}$	Forward on voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_{\text{SD}} = 7.5 \text{ A}$	-		1.6	V
$t_{\text{rr}}$	Reverse recovery time	$I_{\text{SD}} = 7.5 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{\text{DD}} = 60 \text{ V}$ (see <a href="#">Figure 17: "Test circuit for inductive load switching and diode recovery times"</a> )	-	192		ns
$Q_{\text{rr}}$	Reverse recovery charge		-	1.32		$\mu\text{C}$
$I_{\text{RRM}}$	Reverse recovery current		-	13.8		A
$t_{\text{rr}}$	Reverse recovery time	$I_{\text{SD}} = 7.5 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{\text{DD}} = 60 \text{ V}$ , $T_{\text{j}} = 150 \text{ } ^\circ\text{C}$ (see <a href="#">Figure 17: "Test circuit for inductive load switching and diode recovery times"</a> )	-	262		ns
$Q_{\text{rr}}$	Reverse recovery charge		-	1.74		$\mu\text{C}$
$I_{\text{RRM}}$	Reverse recovery current		-	13.3		A

**Notes:**

(1) Pulse width is limited by safe operating area

(2) Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)



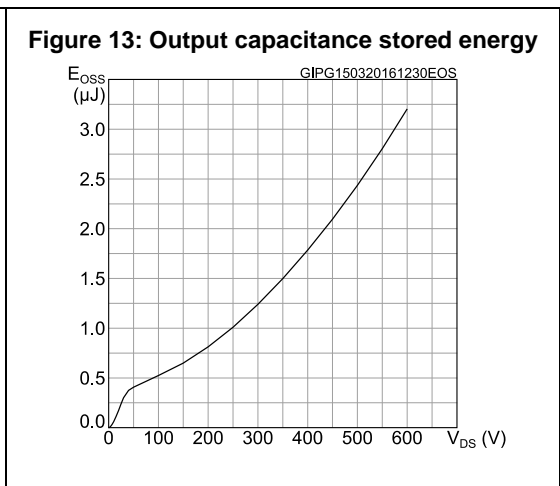
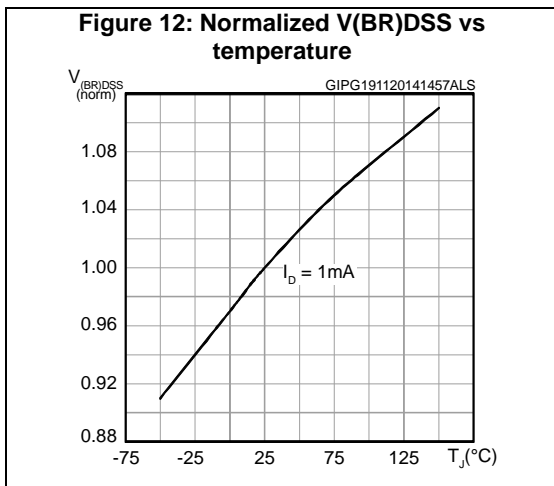
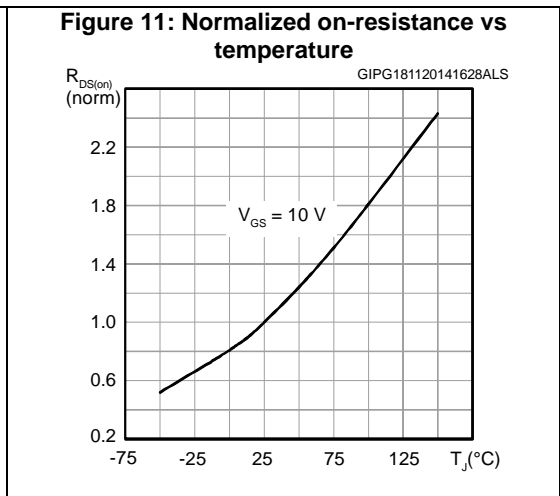
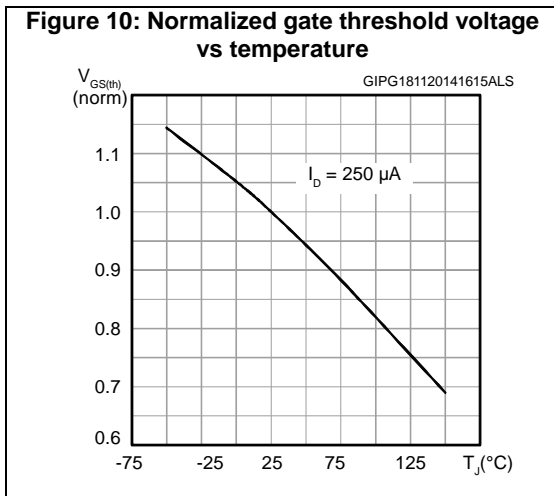
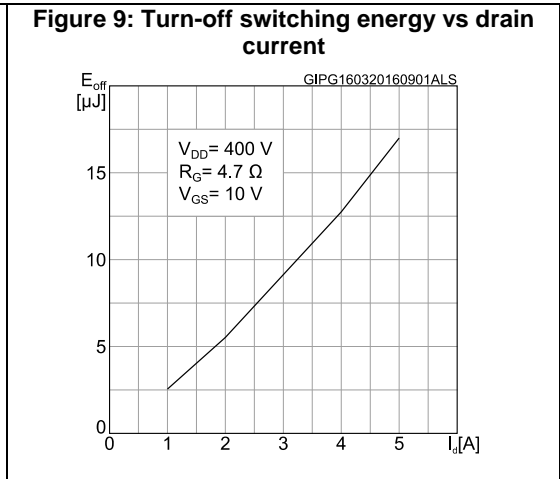
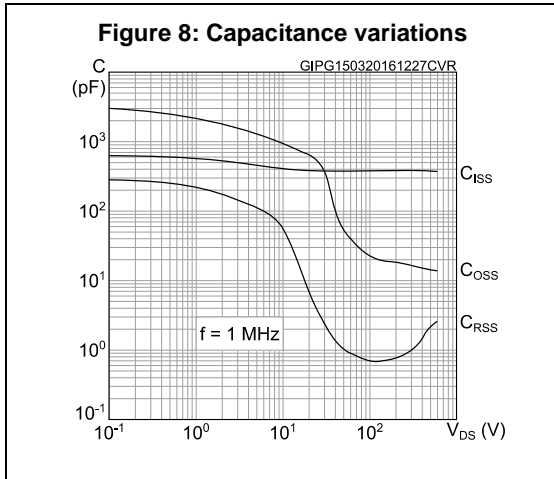
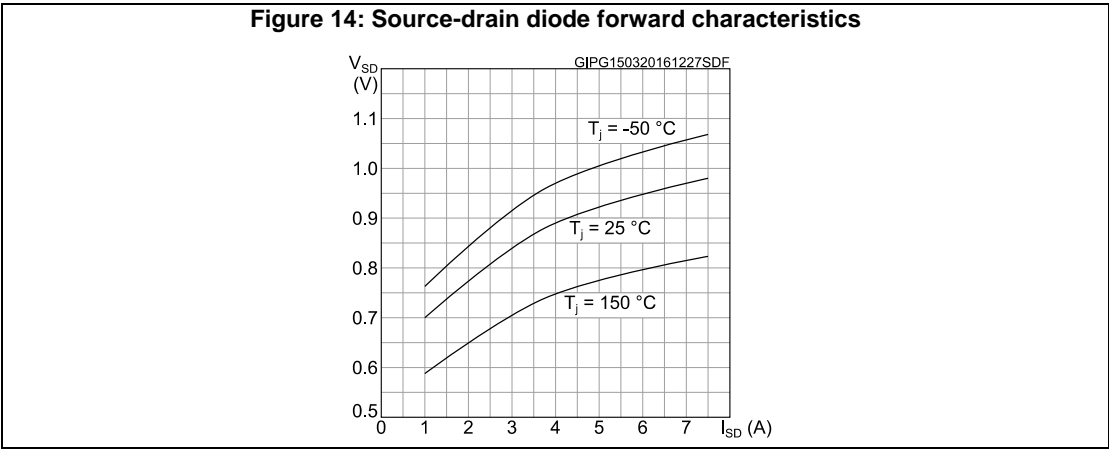


Figure 14: Source-drain diode forward characteristics





### 3 Test circuits

**Figure 15: Test circuit for resistive load switching times**



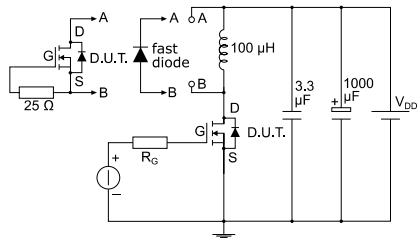
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**Figure 16: Test circuit for gate charge behavior**



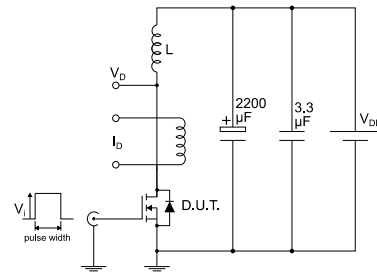
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**Figure 17: Test circuit for inductive load switching and diode recovery times**



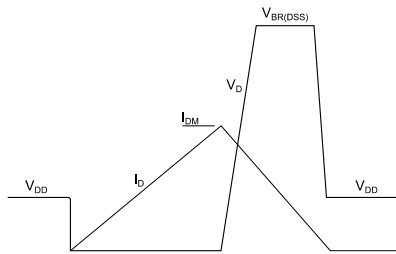
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**Figure 18: Unclamped inductive load test circuit**



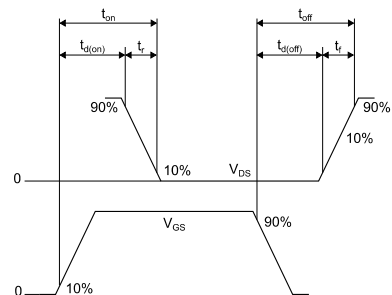
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**Figure 19: Unclamped inductive waveform**



AM01472v1

**Figure 20: Switching time waveform**



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## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.1 I<sup>2</sup>PAKFP (TO-281) package information

Figure 21: I<sup>2</sup>PAKFP (TO-281) package outline

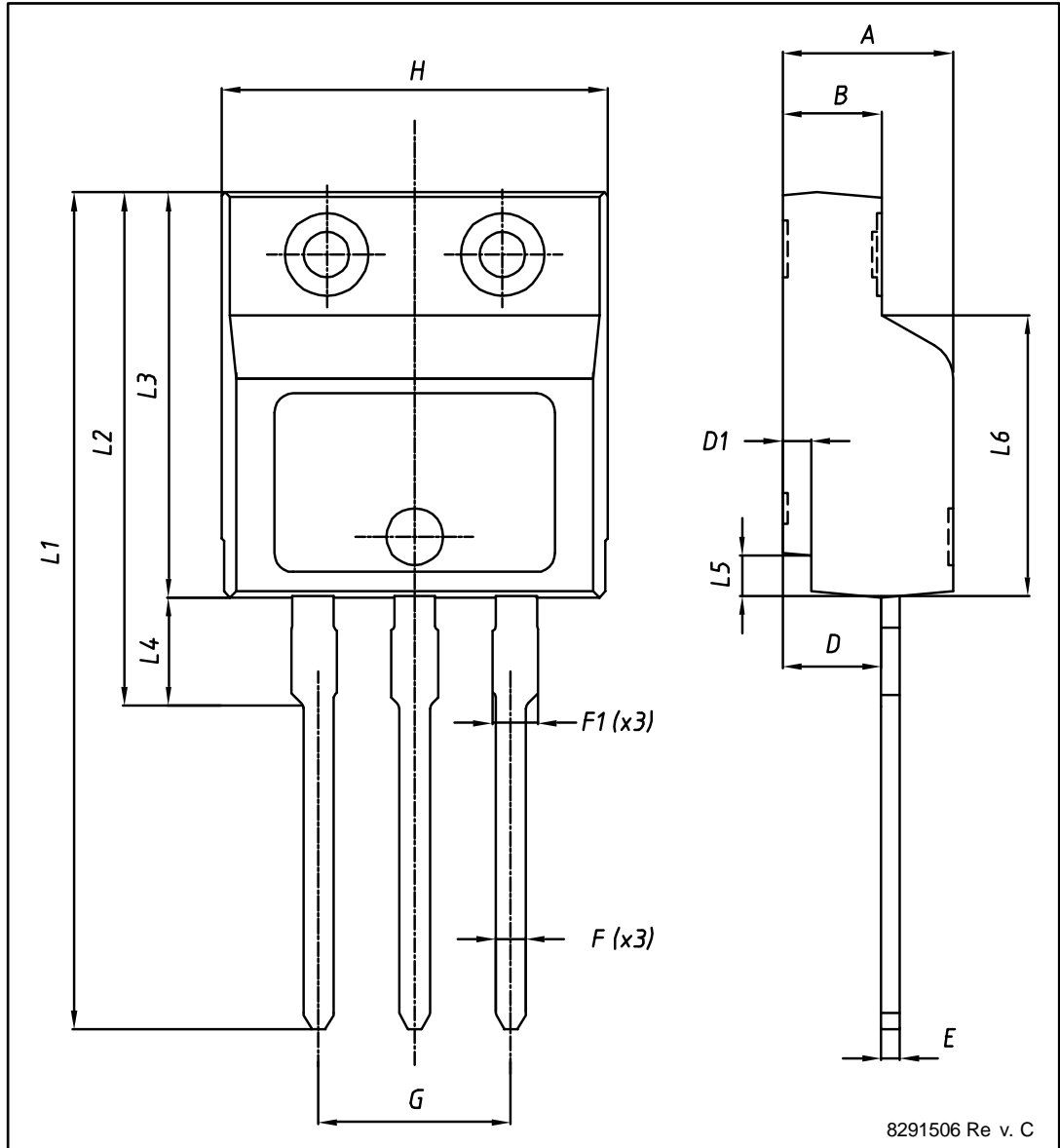


Table 10: I<sup>2</sup>PAKFP (TO-281) mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
B	2.50		2.70
D	2.50		2.75
D1	0.65		0.85
E	0.45		0.70
F	0.75		1.00
F1			1.20
G	4.95		5.20
H	10.00		10.40
L1	21.00		23.00
L2	13.20		14.10
L3	10.55		10.85
L4	2.70		3.20
L5	0.85		1.25
L6	7.50	7.60	7.70

## 5 Revision history

Table 11: Document revision history

Date	Revision	Changes
12-Apr-2016	1	First release.
07-Oct-2016	2	Document status promoted from preliminary to production data.

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